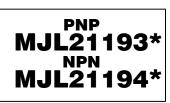


The MJL21193 and MJL21194 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain –

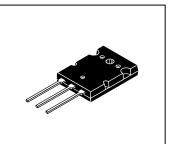
 $h_{FE} = 25 \text{ Min } @ \text{ IC} \\ = 8 \text{ Adc}$

- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second



*ON Semiconductor Preferred Device

16 AMPERE COMPLEMENTARY SILICON POWER TRANSISTORS 250 VOLTS 200 WATTS



CASE 340G-02 TO-3PBL

MAXIMUM RATINGS

Rating	Symb ol	Value	Unit
Collector–Emitter Voltage	VCEO	250	Vdc
Collector-Base Voltage	VCBO	400	Vdc
Emitter–Base Voltage	V _{EBO}	5	Vdc
Collector–Emitter Voltage – 1.5 V	VCEX	400	Vdc
Collector Current — Continuous Peak (1)	IC	16 30	Adc
Base Current – Continuous	ΙB	5	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	PD	200 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	Тј, T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Sym- bol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage (I _C = 100 mAdc, I _B = 0)	VCEO(sus)	250	—	_	Vdc
Collector Cutoff Current ($V_{CE} = 200 \text{ Vdc}, I_B = 0$)	ICEO	_	—	100	μAdc

(1) Pulse Test: Pulse Width = 5.0 μ s, Duty Cycle \leq 10%.

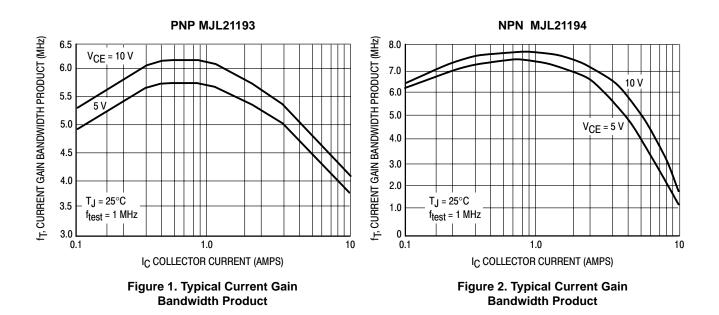
(continued)

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS		•				
Emitter Cutoff Current ($V_{CE} = 5 \text{ Vdc}, I_{C} = 0$)		IEBO	_	—	100	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)		ICEX	_	—	100	μAdc
SECOND BREAKDOWN						
Second Breakdown Collector Current with Base Forward Biased (V _{CE} = 50 Vdc, t = 1 s (non–repetitive) (V _{CE} = 80 Vdc, t = 1 s (non–repetitive)		I _{S/b}	4.0 2.25			Adc
ON CHARACTERISTICS						
DC Current Gain $(I_C = 8 \text{ Adc}, V_{CE} = 5 \text{ Vdc})$ $(I_C = 16 \text{ Adc}, I_B = 5 \text{ Adc})$		hFE	25 8		75 —	
Base–Emitter On Voltage (I _C = 8 Adc, V _{CE} = 5 Vdc)		V _{BE(on)}	_	—	2.2	Vdc
Collector–Emitter Saturation Voltage $(I_C = 8 \text{ Adc}, I_B = 0.8 \text{ Adc})$ $(I_C = 16 \text{ Adc}, I_B = 3.2 \text{ Adc})$		VCE(sat)	_		1.4 4	Vdc
DYNAMIC CHARACTERISTICS						
Total Harmonic Distortion at the Output V _{RMS} = 28.3 V, f = 1 kHz, P _{LOAD} = 100 W _{RMS}	hFE unmatched	T _{HD}		0.8		%
(Matched pair h _{FE} = 50 @ 5 A/5 V)	hFE matched		_	0.8 0.08		
Current Gain Bandwidth Product (I _C = 1 Adc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)		fT	4	—	—	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)		C _{ob}	_	—	500	pF

(1) Pulse Test: Pulse Width = $300 \ \mu$ s, Duty Cycle $\leq 2\%$



TYPICAL CHARACTERISTICS

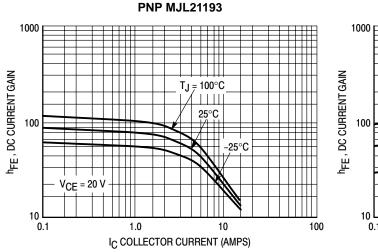
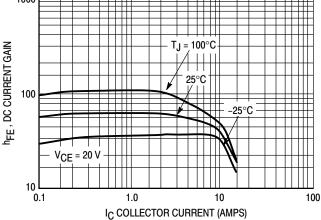


Figure 3. DC Current Gain, V_{CE} = 20 V



NPN MJL21194

Figure 4. DC Current Gain, V_{CE} = 20 V

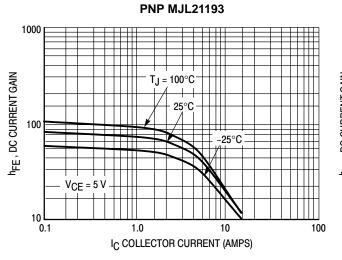


Figure 5. DC Current Gain, VCE = 5 V



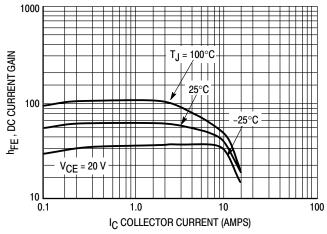
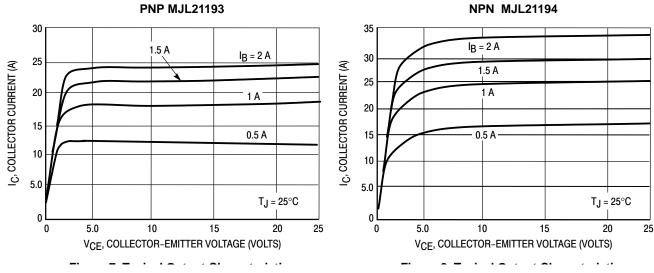


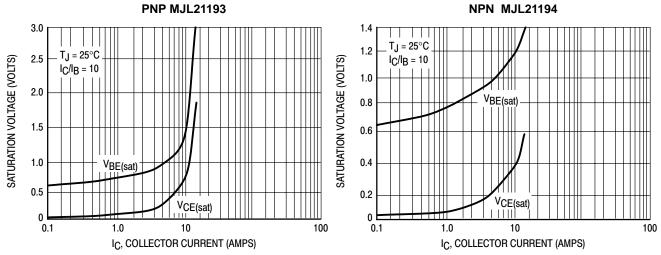
Figure 6. DC Current Gain, VCE = 5 V



PNP MJL21193

http://onsemi.com

TYPICAL CHARACTERISTICS







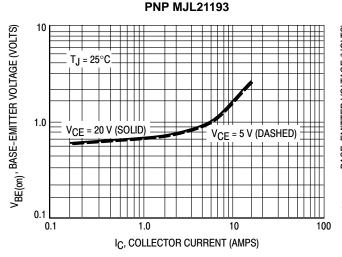
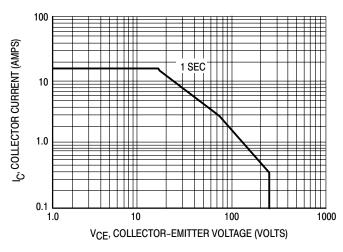
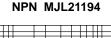


Figure 11. Typical Base–Emitter Voltage







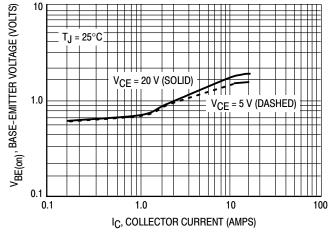


Figure 12. Typical Base–Emitter Voltage

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 150^{\circ}$ C; T_C is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

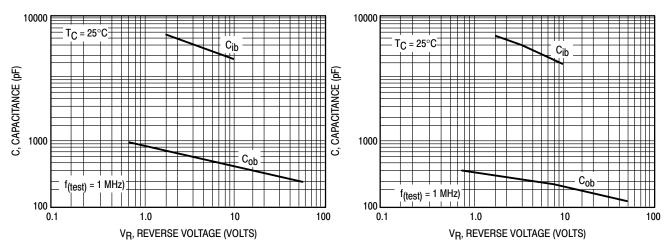


Figure 14. MJL21193 Typical Capacitance

Figure 15. MJL21194 Typical Capacitance

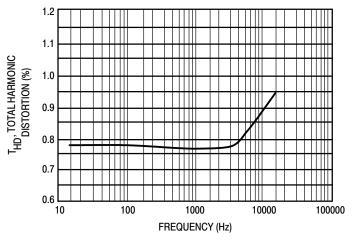


Figure 16. Typical Total Harmonic Distortion

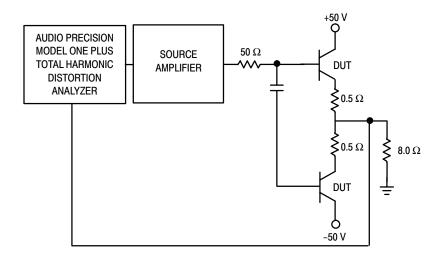
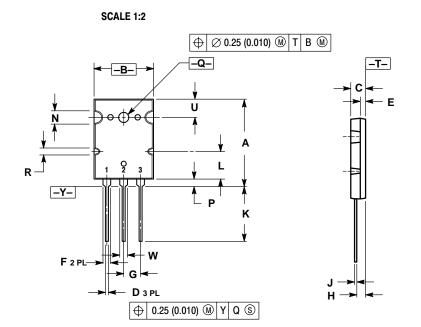


Figure 17. Total Harmonic Distortion Test Circuit

PACKAGE DIMENSIONS

TO-3PBL (TO-264) CASE 340G-02 **ISSUE H**



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2 CONTROLLING DIMENSION: MILLIMETER.

2.	CONTROLLING DIMENSION: MILLIMETE

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	28.0	29.0	1.102	1.142	
В	19.3	20.3	0.760	0.800	
С	4.7	5.3	0.185	0.209	
D	0.93	1.48	0.037	0.058	
Е	1.9	2.1	0.075	0.083	
F	2.2	2.4	0.087	0.102	
G	5.45 BSC		0.215 BSC		
н	2.6	3.0	0.102	0.118	
J	0.43	0.78	0.017	0.031	
K	17.6	18.8	0.693	0.740	
L	11.0	11.4	0.433	0.449	
Ν	3.95	4.75	0.156	0.187	
Ρ	2.2	2.6	0.087	0.102	
Q	3.1	3.5	0.122	0.137	
R	2.15	2.35	0.085	0.093	
U	6.1	6.5	0.240	0.256	
W	2.8	3.2	0.110	0.125	

<u>Notes</u>

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